Quality Control (QC) preparation for the NSW Micromegas anode board production

Fabian Kuger<sup>1, 2</sup>, for the ATLAS Micromegas group

<sup>1</sup>Julius Maximilians Universität Würzburg (Germany), <sup>2</sup>CERN



### The ATLAS NSW Upgrade

The innermost forward detector wheels of the ATLAS Muon system will undergo an upgrade during LHC Long Shutdown 2 (2019/2020) → New Small Wheels (NSW)



The NSWs will comprise an active detector area of 2x1280m<sup>2</sup>, divided in 128 MM Quadruplets of 4 different types and 192 sTGC Quadruplets of 6 different types with more than 2 M channels.

The NSWs shall provide Muon  $p_T$  measurement with **10% resolution at 1 TeV** (offline) and contribute to the improved **Level 1** (1mrad accuracy).



### NSW MM anode boards

The readout PCBs are the critical item for the Micromegas construction, which have to be produced in industries

Zoom of the

board surface with a pillar



- 415/450 μm strip pitch 300 μm width 1022 strips/board
- Screen-printed resistive pattern (~1 MΩ/□, 415/450 µm pitch 300 µm width, interconnections every 10 mm)
- Two HV sectors for each board: resistive strips interrupted in the middle
- Pillars 128 µm height, 280 µm diameter
- Strips routed to the left (bottom half) and right (top half) to pads for elastomeric connector (Zebra)

Surface structure of the board, with regular patterns of pillars and interconnections of resistive strips

Centre-top hole for detector assembly. Visible are the routing of the readout strips around the hole and the central separation of the resistive pattern

Pads for elastomeric connector (Zebra)

Zoom of the resistive strip interconnections

Example of NSW Micromegas anode board (smallest type)



#### NSW MM anode boards

CERN



Schematic of the **NSW Micromegas anode board** layers and dimensions of its main structures (not to scale).



Process chart of the anode board construction: I. Copper pattern creation; II. Connector pad plating; III. Kapton® foil cutting; IV. Kapton® -PCB gluing; V. Silver conduct application; VI. Pillar pattern creation; VII. Cutting and drilling.

- All production steps are standard in industries, still
  - the combination of these steps is rather uncommon,
  - the large size (0.6 x 2.2m<sup>2</sup>) complicates production,
  - the stringent quality requirements result in a considerable challenge for PCB producers.
- → Significant delays for Module-0 PCB order due to production faults / insufficient quality / very low yield.

Lessons learned and actions taken on the PCB production:

- → Strengthen the In-Industry QC (→ increase yield)
- → Insist on quality requirements, delivery schedules (Improved situation in pre-series / full production contract)
- → Follow-up more closely and more regularly at the producers premises. (Module0, Pre-series, full production)



# QA/QC scheme for MM anode board production







## Final Acceptance QC at CERN (Module-0)

The multitude of QC tests for final anode PCB acceptance at CERN can be grouped in:

- Visual inspection
- **Dimension validation**
- **Drilling and Cutting Accuracy tests** ٠
- **Electrical properties and Resistivity**
- Pillar pattern & height •

### Module-0 PCB QC was based on paper forms:

- + Copy of the report 'travels' with the board to ensure information transfer before DB setup
- Changes are quickly implemented (6 Iterations) +

Systematic search for faults is difficult

Waste of time in copying to DB

		PCB QC Protocol - CERN a	acceptance QC (Version 5)
	a p	Board ID Shipped on	// 20 from □ ELTOS □ ELVIA
	Boar	Received on	/ / 20 by
	Visu al Supplier Inspection reports	The QC expert provided by PCII company are - Complexe and state compliance with all the provided of the provided by the p	Comette:
	Di mension s & Accuracy	Adaptament Targets show an accuracy of Mor repetition or assore believed in trial and the set = Rest-State measurement confirm overall measurements accounty of trials and the set = Rest-State measurement confirm overall measurements accounty of trials and the set = Rest-State measurement confirm overall measurements accounty of trials and the set = Rest-State measurement confirm overall measurements accounty of the set = Normal confirms accounty of the set = Normal	Filler pattern - visual inspection:      0 v andse pills:      0 v pills:      0 v andse pills:      0 v pills: <t< th=""></t<>
	HV Connector & HV In sulation	Insulation between 512 shortened r/o strips and resist. [Charge-up time [s] to reach GE equivalent at 1000?]:	The silver line is correctly positioned, not    □ Yes    □ No      violated at the edges and the HV vias are flat?    Resistance between HV supply point on copper pattern and      resistive layer close to silver line middle/ends.      Left:   MΩ    Right:   MΩ
Copying results fro	Aivites is a line of the second secon	$\label{eq:restrictive} \begin{array}{ccc} Resistivity mapping (final) and comparison to foil measure of the second $	Renerate (Initial, Japan) Table (Pinneranger gener) Distributions alike □ Yes □ No Mapping alike □ Yes □ No R change factor (F/I) Agreement with report □ Yes □ No
paper report to DE	5	The board is compliant with PCB production requirements and a Yes No accepted w.r.t. the supplier.	The board is accepted for NSW Micromegas construction (after repair as stated above) None box / Tone Bipathere

For Module0:

- QC reports are stored together with the pillar height maps and published on a dedicated twiki to be easily accessible for construction sites
- Results are summarized in a (local) SQLite DB 0 for bookkeepina





# Final Acceptance QC at CERN (NSW production)

The testing structure is maintained (although more elaborated in some details) during *NSW production*.

- Visual inspection
- Dimension validation
- Drilling and Cutting Accuracy tests
- Electrical properties and Resistivity
- Pillar pattern & height

The reports will be filled digitally with a custom User Interface, providing a direct link to measurement software (speeding up QC) and to the DataBase (proper storing).



PCB QC Protocol - CERN

Online report to be filled

PCB QC Protocol - CERN acceptance QC







CÉRN

![](_page_8_Picture_0.jpeg)

## QC – Visual inspection (Module-0)

A large variety of defects has been observed on the Module-0 anode boards.

They are rated case-by-case as either:

- **Minor**: if repairable or only localized effect on the detector, if any
- → Non-conformity acceptance considered
- **Major**: non-repairable and effect on the full detector / plane / larger area
- → Rejection mandatory

Only a careful visual inspection by a trained operator can reveal all kind of occurring imperfections.

Localization and classification (if possible) is mandatory.

![](_page_8_Picture_10.jpeg)

Bubbles on the resistive surface, caused by air enclosures between the PCB and the Kapton foil (left) and a series of folds in the foil.

![](_page_8_Picture_12.jpeg)

Strip repairs causing a bump in the active area (middle) and fiber enclosed in the glue between PCB and Kapton (right).

![](_page_8_Picture_14.jpeg)

![](_page_8_Picture_15.jpeg)

Two examples of contaminations: A piece/drop of metalized glue or silver printing paste (left), detergent remnants (right).

![](_page_9_Picture_0.jpeg)

### QC – Visual inspection (NSW production)

Visual inspection remains a key QC, although a lower number of 'new' defects is expected.

(valuable experience from Module-0 in classification of blemishes and test on repair possibilities)

- Localization is done with a coarse ≈10x10 cm<sup>2</sup> 'coordinate system', referring to the center of each board.
- Classification is supported by choices of known / observed blemishes
- For in-classifiable cases (microscope) pictures can be added

![](_page_9_Picture_7.jpeg)

![](_page_10_Picture_0.jpeg)

The Alignment between resistive pattern and readout strips can be checked:

- Very quick by looking at the interference pattern on a light table
- Measured visually by using Alignment Markers on the foil and board

![](_page_10_Picture_5.jpeg)

![](_page_10_Picture_6.jpeg)

Backside Illuminated PCB showing the interference pattern between resistive layer and readout strips, corresponding to a ≈600µm left-right misalignment.

![](_page_10_Figure_8.jpeg)

copper pattern on FR4

New: +2 targets

for CERN QC

Alignment of copper- to resistive pattern is directly measureable counting 200µm wide lines / spaces.

In this example:  $\Delta x = +1.0$ mm  $\Delta y = +0.4$ mm

![](_page_11_Picture_0.jpeg)

![](_page_11_Picture_1.jpeg)

## **Dimension validation**

![](_page_12_Picture_0.jpeg)

# QC – Dimension (global)

Inaccuracy / deformations in the cu pattern are critical blemishes of the boards. Although measurement during production (AOI) are required we need a method to cross-check these results.

Only 'global' pattern deformations are likely, not local displacements

![](_page_12_Picture_4.jpeg)

Linear shrink or elongation in long direction (<100µm/m)

![](_page_12_Picture_6.jpeg)

Linear shrink or elongation in Short direction (<100µm/m)

![](_page_12_Picture_8.jpeg)

'banana-shape' deformation  $\rightarrow$  Non linearity of the strips

Testing the three parameters: x-elongation, y-elongation and strip linearity (on with sufficient high granularity) could identify all modes of global deformation

![](_page_13_Picture_0.jpeg)

## QC – Dimension (global) (Module-0)

During *Module-0 PCB* QC dimensions have been measured using a microscope table  $(1,80 \times 1,20)$  with an accuracy of  $\pm 20 \mu m$ .

- $\rightarrow$  Very time consuming ( $\approx$  30min / board)
- → Repeatability of measurements is limited, accordingly only distances are measured.

![](_page_13_Picture_5.jpeg)

![](_page_13_Figure_6.jpeg)

![](_page_13_Figure_7.jpeg)

![](_page_13_Picture_8.jpeg)

![](_page_13_Picture_9.jpeg)

![](_page_14_Picture_0.jpeg)

For *NSW production* the position of Rasnik Masks (3x left, 3x right – both coordinates) + Anode strips in the center (one coordinate only) are measured simultaneously using a precision table with in-build C-CCDs.

![](_page_14_Picture_3.jpeg)

In this configuration we have good control over x-elongation, y-elongation and 'limited' access to and strip linearity (3 points over up to 2m length)

Tooling and Software development is ongoing, expected time <3min / board.

![](_page_15_Picture_0.jpeg)

# QC – Dimension (local) (NSW production)

DL8 L=0.223 mi DL5 L=0.223 mr

DL1 L=0.176 mn

Additionally the **local strip / gap width accuracy** has to be checked. (e.g. on the Zebra-Connector Pads an accuracy of ±20µm is required.)

![](_page_15_Picture_3.jpeg)

Systematic width deviation of  $15\mu m \rightarrow acceptable$ 

Width of by  $24\mu m$  $\rightarrow$  Not within specification

DL2 L=0.176 mr DL6 \_=0.225 mr

*Module-0:* Measurements with a calibrated Microscope and manual image evaluation has been performed (2-3min / picture  $\rightarrow$  >5min / board)

*NSW production:* Pattern recognition for automatized measurements (c-CCD) (<1min per point  $\rightarrow$  1-2min / board)

![](_page_16_Picture_0.jpeg)

![](_page_16_Picture_1.jpeg)

# Drilling and Cutting Accuracy

![](_page_17_Picture_0.jpeg)

#### QC – Drilling accuracy (Module-0)

The position of the (no-precise / mechanical) holes in the PCB is required to be accurate to  $\pm 100 \mu m$ .

Judging this visually is difficult, especially in regions where no concentric Cu-pattern is around.

Measurements with a calibrated microscope are time consuming >1min / hole.

![](_page_17_Figure_5.jpeg)

Example measurements of the hole accuracy: The distance between copper pattern hole and drilled hole varies between  $300-420\mu m$  (left) resp. 250-510  $\mu m$  (right), equivalent to a  $\approx 60 \ \mu m$  (accepted) resp. 130  $\mu m$  (non-conform) displacement of the hole centers.

![](_page_17_Picture_7.jpeg)

![](_page_17_Picture_8.jpeg)

![](_page_17_Picture_9.jpeg)

Examples of inaccurately drilled holes on Module-0 PCBs.

![](_page_18_Picture_0.jpeg)

For *NSW production* we added an extra ring in the Cu pattern around the nominal hole position allows for quicker visual QC tests:

![](_page_18_Figure_3.jpeg)

During NSW production all hole positions can be checked visually to be within / out of specifications in less than 1min.

![](_page_19_Picture_0.jpeg)

The distance between the last r/o strip and the PCB edge is required to be  $300 \pm 100 \mu m$ .

![](_page_19_Picture_3.jpeg)

Cutting Edge too close (left) to the last strip, violating or removing a r/o strip or too far (right) causing interference when joining two boards.

During *Module-0 PCB* QC the distance between last r/o strip and PCB edge has been measured with a calibrated microscope manual image evaluation has been performed ( $\approx 1/2 \text{ min}$  / picture  $\rightarrow 5 \text{ min}$  / board)

![](_page_19_Figure_6.jpeg)

Examples for direct (left) and indirect (middle) strip-edge to cutting-edge measurement and a calibration measurement (right). The left picture shows a clean cut while in the middle picture the cut is full of Kapton splinters.

![](_page_20_Picture_0.jpeg)

To speed up this procedure additional QC markers have been added on the Cu-pattern for *NSW production*.

![](_page_20_Picture_3.jpeg)

#### Before cutting:

The nominal cutting line goes through the center of the pattern

![](_page_20_Picture_6.jpeg)

Line /gap width 100μm, shift of 50 μm

#### After cutting:

![](_page_20_Picture_9.jpeg)

The cut chops part of the pattern away and the deviation can be counted by counting lines

![](_page_20_Picture_11.jpeg)

One line on the right the full gap in the middle are visible, indicating an ≈150µm shifted cut.

The cut position is checked on the sides and the linearity of the cut is tested by pressing against a rectified bar on an illuminated table.

 $\rightarrow$  A quick acceptance decision can be taken visually within < 1min.

![](_page_21_Picture_0.jpeg)

![](_page_21_Picture_1.jpeg)

# Electrical properties and Resistivity

![](_page_22_Picture_0.jpeg)

QC tests on the electrical properties of the anode boards comprise:

- Insulation test between R/O strips and resistive layer (≈4 min)
- Conductivity of the HV-distribution line (≈ 2 min)
- R-mapping of the resistive layer (point-point or point to HV-distr.) (20-30 min)
- Capacitance Measurement between between R/O strips and resistive layer (~2 min)

Strong correlation to violated / cut strips. Important test for the functionality of the detector Turned out to be dominated by fluctuations in R.

![](_page_23_Picture_0.jpeg)

QC tests on the electrical properties of the anode boards comprise:

- Insulation test between R/O strips and resistive layer
- Conductivity of the HV-distribution line
- R-mapping of the resistive layer (point-point or point to HV-distr.)
- Capacitance Measurement between between R/O strips and resistive layer

Fruitful collaboration between Kobe (Japan), Würzburg (Germany) and CERN resulted in a very elaborated R-mapping tool & software.  $\rightarrow$  < 5 min / foil or board (both mappings)

![](_page_23_Figure_8.jpeg)

Combined in

measurement

one

![](_page_24_Picture_0.jpeg)

![](_page_24_Picture_1.jpeg)

![](_page_25_Picture_0.jpeg)

Missing pillars turned out to be one of the major problems during Module-0 PCB production.

Completeness of the pillar pattern can be best checked visually using light reflection.

The test can be simplified by using UV-light. (requiring darkness, difficult to achieve homogeneous UV illumination over the full PCB surface)

With normal light, the reflection can be magnified with a foil sucked over the PCB (vacuum bag / vacuum table)

![](_page_25_Picture_6.jpeg)

Enhanced visibility of the pillar pattern under a vacuum sucked Mylar foil.

![](_page_25_Picture_8.jpeg)

![](_page_25_Picture_9.jpeg)

Pillar visibility under UV illumination.

![](_page_26_Picture_0.jpeg)

# QC - pillar pattern & - height

The height of the pillars defined the Micromegas amplification gap and accordingly the gas gain of the chamber.

Few µm variation can have a large impact on the response-homogeneity / efficiency.

The mean pillar height is mapped over the full surface of each board:

Module-0: 3-6min (measurements) + 3-4min (data processing) per board

#### NSW production:

Direct interface between analysis program and measurement tool speeds up the Measurement significantly. (<5min / board)

![](_page_26_Figure_8.jpeg)

Sigma (excl)

μm

5,5

∆ Average top-bottom

μm

1,3

Average (excl)

μm

124,5

µm-length gauge

steel carrier with precision slots for

ecision surface

(bottom)

PCB board with pillar structure

∆ Average left-right

μm

4,0

![](_page_27_Picture_0.jpeg)

Module-0 experience has proven very valuable in terms of QC optimization

- Measurement ideas have been tested (HV insulation, C-measurement...)
- Visual inspection has become more systematic and 'more objective'
- Methods have been optimized (R-measurements, pillar height...)
- Introduction of QC-Markers in the PCB design facilitates QC significantly
- All QC methods/ processes are 'speeded up'
  (≈2h / board for Module-0 → 30-40 min / board envisaged during NSW production)
- Last tools are currently build and will become available in the next months
- Digitalization (+ DB interface) of all processes is ongoing and will be ready before start of NSW mass production.

![](_page_28_Picture_0.jpeg)

![](_page_28_Picture_1.jpeg)

ÇÊRN

![](_page_29_Picture_0.jpeg)

### Backup – NSW MM anode boards production steps

CERN

- I. Copper pattern creation by photolithography
  → Standard operation for PCB manufacturer except for board size (length; width is standard)
- II. Selective plating on connector pads
- → Standard operation for PCB manufacturer
- III. Cutting of Kapton foils with resistive pattern
- → Non-standard operation but not critical (accuracy ±1 mm)
- IV. High pressure Gluing of Kapton foil on the PCB
- → High pressure gluing is part of PCB manufactures, complexity arises from board size and non-standard material (Kapton with resistive pattern)
- V . Connection between HV input line and resistive strips (screen printed: silver conductive paste)
- → Simple operation to be done manually
- VI. Pillar creation (2x 64µm Pyralux coverlay)
- → Standard operation with a highly 'non-standard' pattern (pillars)
- VII. Cutting of the boards and drilling of the non-precision holes (holes for mechanical assembly and alignment)
- → Standard operation on CNC machine

![](_page_29_Figure_16.jpeg)

![](_page_30_Picture_0.jpeg)

#### Production done in industry – stringent requirements

#### I. Copper pattern creation by photolithography

- Copper pattern absolute accuracy: <30 µm for the short side and <100 µm/m for the long side</li>
- o Line and space accuracy 20% w.r.t. the design file
- o Maximum 1% of cut on the copper lines, as long as cuts are not on neighboring lines
- Maximum of 0.1% of shorts between two lines, as long as no more than two successive lines are shorted

#### II. Selective plating on connector pads

o Layer thickness depending on plating choice: Au/Ag/Pd

#### III. Cutting of Kapton foils with resistive pattern

o Cutting accuracy shall be better than ±1mm

#### IV. High pressure Gluing of Kapton foil on the PCB

- o Alignment accuracy shall be better than ±0.5mm
- V. Connection between HV input line and resistive strips (screen printed: silver conductive paste)
- Position accuracy w.r.t. the copper pattern < ±1m</li>
- Resistance of the silver HV connection line < 10Ω</li>

#### VI. Pillar creation (2x 64µm Pyralux coverlay)

- Coverlay pattern absolute accuracy < ±1 mm</li>
- Accuracy of the diameter of the pillars ±25 µm
- o Missing pillars maximum 0,1% of the total number, as long as no neighboring pillars are missing
- Max. 10 extra coverlay structures of a size < 1mm in each dimension are tolerated per square meter
- The mean height of the coverlay layer / pillars in different 25x25 cm<sup>2</sup> regions has to be homogeneous on a level of <5µm over the full surface of the board</li>

# VII. Cutting of the boards and drilling of the non-precision holes (holes for mechanical assembly and alignment)

- o Cutting absolute accuracy w.r.t. the copper pattern shall be better than ±100µm
- Holes absolute position accuracy referring to the copper pattern shall be at least ±100µm

![](_page_30_Figure_26.jpeg)

![](_page_31_Picture_0.jpeg)

# CERN

#### Conduct QC tests as fine-meshed as possible

The complexity of the process and lacking experience of large-area PCB production in industries requires **multiple QC steps** during the different steps of PCB production. This as well avoids unqualified parts to be further processed.

#### Shifting QC as close to industries as possible

QC/QA shall be performed in industries and by industries personal whenever possible. This requires setups to be exported to industries which are **reliable**, **simple** and **time efficient to use** and provide accurate and repeatable QC results independent of the testing person. These requirements lead to largely automatized measurements, minimizing processes involving human handling.

#### Keeping track of QC tests and results

Giving QC measurements to industries fortifies the need of proper bookkeeping. A database developed centrally by the NSW collaboration will be used to store all the information and results of each QC steps, including visual inspection of components with passed/not passed results.

#### Maintaining QC pressure on industries

Minimizing the risk of negligent performed test in industries, CERN will requiring the possibility to re-test individual batches. This requires producing **two sets of testing tools** and manpower/ responsible to keep track of the production and QA/QC. **Regular visits** to the industry premises are also foreseen to verify the respect of the defined procedures.